

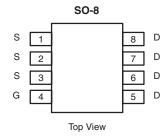
N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0042 at V _{GS} = 10 V	28	29 nC			
30	0.0057 at V _{GS} = 4.5 V	24	28110			

FEATURES

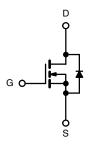
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET[®] Power MOSFETs
- 100 % R_g Tested





Ordering Information: Si4842BDY-T1-E3 (Lead (Pb)-free)

Si4842BDY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V _{GS}	± 20	V
	T _C = 25 °C		28	
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	1 1	23	
Continuous Diain Current (1) = 130 °C)	T _A = 25 °C	l l _D	20 ^{b, c}	
	T _A = 70 °C	1	16 ^{b, c}	Α
Pulsed Drain Current		I _{DM}	60	
Continuous Source-Drain Diode Current	T _C = 25 °C		5.6	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.7 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	35	
Avalanche Energy		E _{AS}	61	mJ
	T _C = 25 °C		6.25	
Maximum Dawar Dissination	T _C = 70 °C	P _D	4.0	W
Maximum Power Dissipation	T _A = 25 °C	1 'D	3.0 ^{b, c}	VV
	T _A = 70 °C	1	1.9 ^{b, c}	
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	32	42	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	15	20	O/ V V		

Notes:

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 90 $^{\circ}\text{C/W}.$

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Drain-Source Breakdown Voltage V_DS V_GS = 0 V, I_D = 1 mA 30	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
V _{Ds} Temperature Coefficient Λ/V _{Ds} /T _J V _{Os(m)} Temperature Coefficient Λ/V _{Ds} /T _J V _{Os(m)} Temperature Coefficient Λ/V _{Ds} /T _J V _{Os(m)} Temperature Coefficient Λ/V _{Ds} /T _J V _{Ds} = 250 μA 30 mV/V Gate-Source Threshold Voltage V _{Os(m)} V _{Ds} = 0V, V _{Os} = 20 V ± 100 nA 30 y 100 nA 1.4 30 V x 100 nA 1.4 30 V x 100 nA 1.4 30 V x 100 nA x 100 n	Static						l.	
Vos(m) Temperature Coefficient ΔV _{GS(m)/TJ} (aste-Source Threshold Voltage V _{GS(m)} (by Gate-Source Leakage I do Source L	Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 1 mA	30			V	
Vosyiny Temperature Coefficient ΛV _{GS(M)} V _{GS(M)} V _{DS} = V _{GS} , I _D = 250 μA 1.4 3 V Gate-Source Threshold Voltage I _{GSS} V _{DS} = 0 V, V _{GS} = ±20 V ±100 nA Zero Gate Voltage Drain Current I _{GSS} V _{DS} = 30 V, V _{GS} = 0 V 1 μ On-State Drain Current ^a I _{D(on)} V _{DS} = 30 V, V _{GS} = 10 V 30 A On-State Resistance ^a P _{DS} = 10 V, I _D = 20 A 0.0034 0.0042 A Drain-Source On-State Resistance ^a P _{DS} = 15 V, V _{GS} = 15 V, I _D = 20 A 0.0047 0.0057 A Forward Transconductance ^a 9ts V _{DS} = 15 V, I _D = 20 A 90 S S Dynamic ^b V _{DS} = 15 V, I _D = 20 A 90 S S Dynamic ^b S Dy	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		30		mV/°C	
Gate-Source Leakage IGSS VDS = 0 V, VGS = ± 20 V ± 100 nA	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.4			
Gate-Source Leakage I_GSS V_DS = 0 V, V_GS = ± 20 V ± 100 nA V_DS = 30 V, V_GS = 0 V T_J = 55 °C 10 10 V_DS = 30 V, V_GS = 0 V T_J = 55 °C 10 10 V_DS = 30 V, V_GS = 0 V T_J = 55 °C 10 10 V_DS = 5 V, V_GS = 10 V 30 0.0042 0.0057 V_DS = 5 V, V_GS = 10 V 30 0.0047 0.0057 V_DS = 5 V, V_DS = 15 V 0.0047 0.0057 0.0057 V_DS = 15 V, V_DS = 15 V 0.0047 0.0057 0.0057 V_DS = 15 V, V_DS = 15 V 0.0047 0.0057 0.0057 V_DS = 15 V, V_DS = 15 V 0.0047 0.0057 0.0057 V_DS = 15 V, V_DS = 15 V 0.0047 0.0057 0.0057 V_DS = 15 V, V_DS = 10 V 0.0057 0.0057 0.0057 V_DS = 15 V, V_DS = 10 V 0.0057 0.0057 0.0057 0.0057 V_DS = 15 V, V_DS = 10 V 0.0057 0.0057 0.0057 0.0057 V_DS = 15 V, V_DS = 10 V 0.0057 0.0057 0.0057 0.0057 0.0057 0.0057 0.0057 V_DS = 15 V, V_DS = 10 V 0.0057 0.0	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.4		3	٧	
Description	Gate-Source Leakage	-	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
On-State Drain Current [®] I _{D(on)} V _{DS} = 30 V, V _{GS} = 10 V 30 A Drain-Source On-State Resistance [®] P _{DS} (on) V _{GS} = 10 V, I _D = 20 A 0.0034 0.0047 0.0057 Forward Transconductance [®] 9I _S V _{DS} = 15 V, I _D = 15 A 0.0047 0.0057 Ω Every Transfer Capacitance C _{ISS} V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz 3650 pp pF Reverse Transfer Capacitance C _{ISS} V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz 635 pp pF Reverse Transfer Capacitance C _{ISS} V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz 635 pp pF Total Gate Charge Q _g V _{DS} = 15 V, V _{GS} = 10 V, I _D = 25 A 68 100 nC Gate-Source Charge Q _{gs} V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 25 A 9.4 nC Gate Polari Charge Q _{gs} f = 1 MHz 1.25 2 Ω Gate Polari Charge I _d (off) V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 25 A 9.4 nC Turn-On Delay Time I _d (off) I _d (off) I _D = 10		1 .	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	1		1	<u> </u>	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			A	
Provided Transconductance Pale Vas = 4.5 V, I _D = 15 A Pale Vas = 15 V, I _D = 20 A Pale Vas = 15 V, I _D = 20 A Pale Vas = 15 V, I _D = 20 A Pale Vas = 15 V, I _D = 20 A Pale Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas = 15 V, Vas = 10 V, I _D = 25 A Vas = 15 V, Vas			V _{GS} = 10 V, I _D = 20 A		0.0034	0.0042		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Drain-Source On-State Resistance ^a	H _{DS(on)}	V _{GS} = 4.5 V, I _D = 15 A		0.0047	0.0057	Ω	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		90		S	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic ^b						l	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	•	C _{iss}			3650			
Reverse Transfer Capacitance Crss 300 3			$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		635		pF	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance		20 00		300			
		V _{DC} =	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 25 A		68	100	nC	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Q_g			29	43		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Charge	Q _{gs}			12.6			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Drain Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 25 \text{ A}$		9.4			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Resistance	Rg	f = 1 MHz		1.25	2	Ω	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-on Delay Time	t _{d(on)}			125	190		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time		V 45VP 450		190	280		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(off)}	== =		38	60		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t _f	1D = 10 A, VGEN = 4.3 V, Fig = 1.32		13	20		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-on Delay Time	t _{d(on)}			15	25		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t _r	V 45VP 450		15	25	ns	
Fall Time $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(off)}			42	65		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time		ID = IOA, $VGEN - IOV$, $IIg - IS2$		8	15		
Pulse Diode Forward Current ^a I_{SM} 60 Body Diode Voltage V_{SD} $I_S = 2.7 A$ 0.74 1.1 V Body Diode Reverse Recovery Time t_{rr} 34 55 ns Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 10 A$, $dI/dt = 100 A/\mu s$, $T_J = 25 ^{\circ}C$	Drain-Source Body Diode Characteristic	s				1		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.6		
Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 10 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$ 18 18	Pulse Diode Forward Current ^a	I _{SM}				60	A	
Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 10 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$ 18 18	Body Diode Voltage	V _{SD}	I _S = 2.7 A		0.74	1.1	V	
Body Diode Reverse Recovery Charge Q_{rr} $I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/µs}, T_J = 25 °C $	Body Diode Reverse Recovery Time				34	55	ns	
Reverse Recovery Fall Time t _a I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C 18	Body Diode Reverse Recovery Charge		1 10 A 41/44 100 A/45 T 05 00		31	50	nC	
ns ns	Reverse Recovery Fall Time		$I_F = 10 \text{ A}, \text{ GI/GT} = 100 \text{ A/}\mu\text{s}, I_J = 25 \text{ °C}$		18			
	Reverse Recovery Rise Time				16		ns	

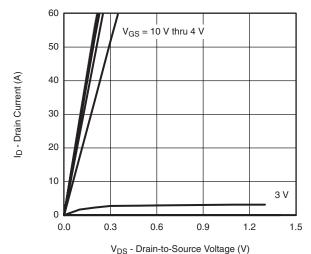
Notes:

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

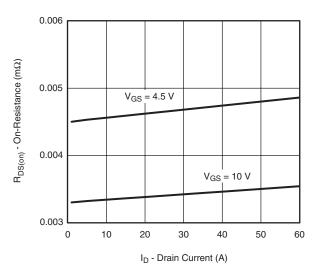


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

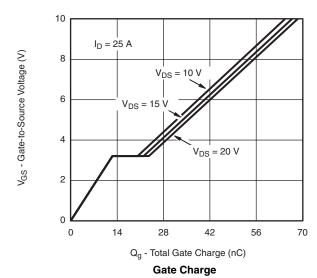


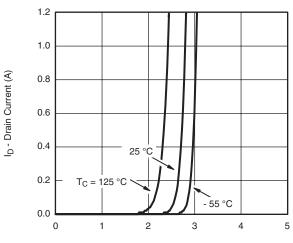
rpg - Brain-to-Source voltage (v





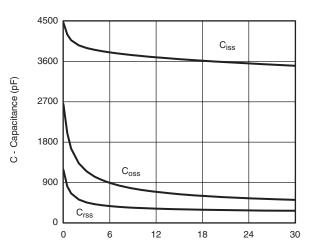
On-Resistance vs. Drain Current and Gate Voltage





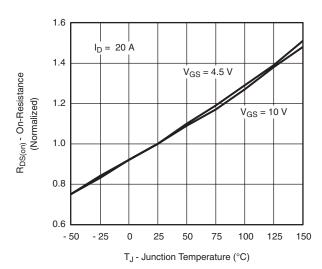
V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



V_{DS} - Drain-to-Source Voltage (V)

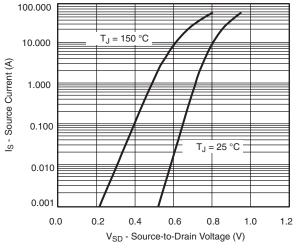
Capacitance



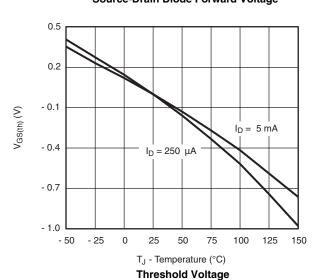
On-Resistance vs. Junction Temperature

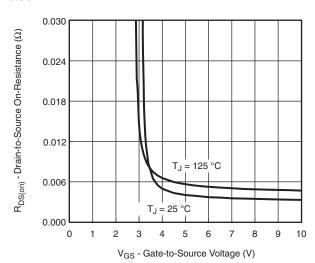
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

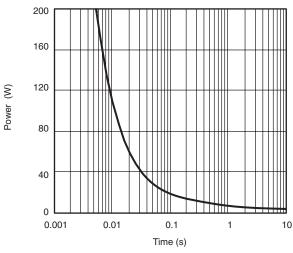




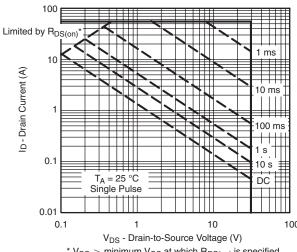




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

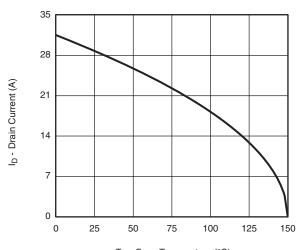


* $V_{GS} > minimum \ V_{GS}$ at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

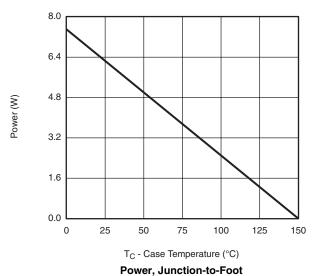


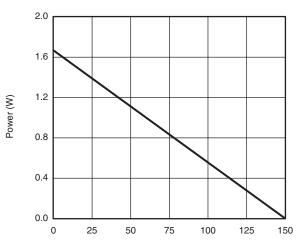
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 $T_{\mbox{\scriptsize C}}$ - Case Temperature (°C)

Current Derating*





T_A - Ambient Temperature (°C)

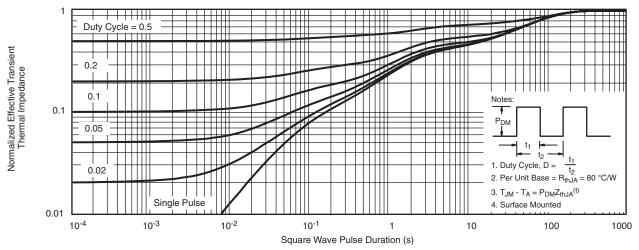
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

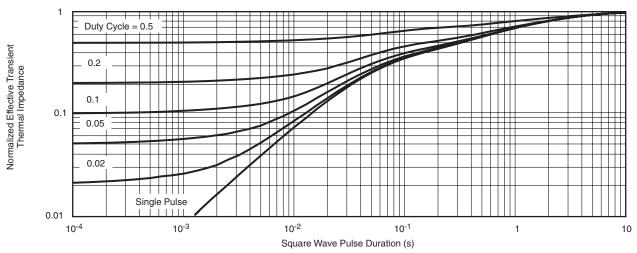
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?73532.

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050) BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
FCN: C-06527-Bey 11-Sen-06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06 www.vishay.com



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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